Search Notes

Application/Control No.	Applicant(s)/F Reexaminatio	pplicant(s)/Patent under eexamination	
10/826,364	MAEDA, TSU	MAEDA, TSUYOSHI	
Examiner	Art Unit		

Long K. Tran

2818

SEARCHED				
Class	Subclass	Date	Examiner	
			-	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
257/59,73 (text search only, see search history printout)	1/26/2006	LKT		
349/39,49,51,54,139 (text search only, see search history printout)	1/25/2006	LKT		